Synthesis and characterization of nanocrystalline Al_{0.5}Ag_{0.5}TiO₃ powder

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Abstract. A low-cost, green and reproducible citric acid assisted synthesis of nanocrystalline $Al_{0.5}Ag_{0.5}TiO_3$ (n-AAT) powder is reported. X-ray, FTIR, energy dispersive X-ray, transmission electron microscopy and scanning electron microscopy analyses are performed to ascertain the formation of n-AAT. X-ray diffraction data analysis indicated the formation of monoclinic structure. Spherical shaped particles having the sizes of 3-15 nm are found. The mechanism of nano-transformation for the soft-chemical synthesis of n-AAT has been explained using simple organic chemistry rules and nucleation and growth theory. Dielectric study revealed that AAT ceramic might be a suitable candidate for capacitor applications.

Keywords: green synthesis; citric acid gel method; nanoparticle; dielectric properties; Al_{0.5}Ag_{0.5}TiO₃

1. Introduction

Perovskite ABO₃–type lead containing materials, such as Pb(Zr,Ti)O₃, Pb(Mg_{1/3}Nb_{2/3})O₃–PbTiO₃ and Pb(Zn_{1/3}Nb_{2/3})O₃–PbTiO₃ in ceramic or crystal form, are being used for different electronic and/or microelectronic devices (Eichel and Kungl 2010, Rödel *et al.* 2009). However, the toxicity of lead oxide and its high vapor pressure during sintering processing cause serious environmental problems. It is, therefore, necessary to develop alternative lead-free materials that should be ecofriendly from the viewpoint of sustainable development (Fancher *et al.* 2013, Prasad *et al.* 2013, Kumari *et al.* 2011, Damjanovic *et al.* 2010, Shrout and Zhang 2007, Takenaka and Nagata 2005, Cross 2004). Among them bismuth sodium titanate, Bi_{0.5}Na_{0.5}TiO₃, discovered by Smolenskii, in 1960, is considered to be an excellent candidate as a key lead-free material, which shows strong ferroelectric properties (Hiruma *et al.* 2009, Prasad *et al.* 2007, Smolenskii *et al.* 1961). Recent works on the identical silver-based compounds such as Bi_{0.5}Ag_{0.5}TiO₃ (Inaguma *et al.* 2001, Park *et al.* 1999), Bi_{0.5}(Na_{1-x-y}K_xAg_y)_{0.5}TiO₃ (Liao *et al.* 2008), Fe_{0.5}Ag_{0.5}TiO₃ (Kumar *et al.* 2013), NaNbO₃-Bi_{0.5}Ag_{0.5}TiO₃ (A = Li, Na, K, Ag) (Raevskii *et al.* 2000), Bi_{0.5}Ag_{0.5}TiO₃ (Lu *et al.* 2007, Lu *et al.* 2008), also showed excellent electrical properties. Further search of new lead-free

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alternative, one such material in this series is perovskite $Al_{0.5}Ag_{0.5}TiO_3$. The material is environment-friendly, mechanically tough and displayed very low loss ~ 10^{-2} which indicates that this compound is having the potential for capacitor applications. Besides, extensive literature survey indicated that no attempt, to the authors' knowledge, has so far been made to study nanocrystalline $Al_{0.5}Ag_{0.5}TiO_3$ (abbreviated hereafter as n-AAT) powder. Accordingly, present work reports the synthesis (using citric acid gel method) of n-AAT and their structural (X-ray and its Rietveld analysis), transmission electron microscopy, scanning electron microscopy and Fourier transformed infrared spectroscopy studies. The dielectric properties have also been carried out to see its potential for capacitor applications. Besides, the mechanism of nanotransformation for the soft-chemical synthesis of n-AAT has been explained using simple organic chemistry rules and nucleation and growth theory.

2. Experimental details

2.1 Synthesis of nanocrystalline Al_{0.5}Ag_{0.5}TiO₃ powder

A citric acid gel method was used to prepare $Al_{0.5}Ag_{0.5}TiO_3$ powder. Citric acid was dissolved into deionized water and the value of the pH of the solution was adjusted to 7–8 by adding the appropriate amount of ammonia solution. Titanium (IV) n-Butoxide (Across, USA) was added to this solution which was vigorously stirred and heated at about 70°C for 1 h on a hot plate. This solution was then added with aqueous solutions of AgNO₃ (Merck, Germany) and Al(NO₃)₃.9H₂O (Across, USA) and stirred at 80°C for 2 h. Further, the precursor solution was dehydrated at 100°C to form a sol. Subsequent heating at a higher temperature of 160°C yield a gel. The gel initially tends to swell and filled the beaker producing a foamy precursor. The gel was pulverized and then heated at 300°C for 2 h in air to get carbonaceous mass. Finally carbonaceous mass was calcined at 700°C for 5 h. Completion of the reaction and formation of the desired compound was checked by X-ray diffraction technique. The as-calcined powder was compacted into thin (~1.5 mm) cylindrical disks with an applied uniaxial pressure of 650 MPa. These pellets were then sintered in air atmosphere at 750°C for 3 h in alumina crucible.

2.2 Characterization

X-ray diffraction (XRD) data of n-AAT were obtained using an X-ray diffractometer (XPERT-PRO, PW3050/60) with CuK_a radiation ($\lambda = 1.5406$ Å) between the angles 20° and 80°. TEM micrographs and selected area diffraction (SAED) and energy dispersive X-ray (EDX) patterns of n-AAT were obtained using High resolution Bruker transmission electron microscope. SEM micrograph of n-AAT was taken using a computer controlled scanning electron microscope (JEOL-JSM840A). The Fourier Transformed Infrared (FTIR) spectrum of n-AAT was collected in the transmission mode using an Alpha-T Bruker FTIR spectrophotometer in the range of 400-4000 cm⁻¹. A sintered pellet was polished and electroded with air-drying silver paste (SPI supplier, USA) to measure the electrical properties. Dielectric measurement was carried out using a computer-interfaced LCR Hi-Tester (HIOKI 3532-50, Japan) in a cooling mode to avoid the moisture, if any. Further, the temperature coefficient of capacitance (T_{CC}) which is an important parameter for the low-temperature dependence of capacitance is defined as: $T_{cc}(\%)=[(C_T-C_{RT})/C_{RT}]\times100$; where C_T and C_{RT} represent the values of capacitance at the elevated and at room temperature, respectively.

3. Results and discussion

Rietveld refinement of the XRD data of n-AAT was carried out, selecting the space group P2/m(10). The XRD (observed, calculated and difference XRD profiles) pattern of n-AAT synthesized using citric acid gel method is presented in Fig. 1. It can be seen that the profiles for observed and calculated one are perfectly matching ($\chi^2 = 1.28$). The profile fitting procedure adopted was minimizing the χ^2 function (McCusker *et al.* 1999). The XRD analyses indicated that n-AAT has a monoclinic unit cell. The crystal data and refinement factors of n-AAT obtained from XRD data are depicted in Table 1. Further, the XRD patterns showed the presence of broad peaks which may be due the nanosizing effect in n-AAT.

Fig. 2 shows the EDX pattern and TEM image (inset) of n-AAT. All the peaks in the EDX pattern have perfectly assigned to the elements present in $Al_{0.5}Ag_{0.5}TiO_3$. This clearly indicated the successful synthesis and purity of chemical composition of n-AAT. The HR-TEM micrograph (inset Fig. 2) clearly illustrates individual nanoparticles which are almost spherical in shape. This observation has also been supported by the SEM micrograph (Fig. 3(ii)) which clearly ensures the formation of spherical nanoparticles of AAT. The particle size distribution histogram of n-AAT is shown in the inset of Fig. 3(i)(a), which shows that the particles having the sizes between 3-15 nm are present in TEM micrograph (Fig. 3(i)). The difference in size may possibly be due to the agglomeration of individual nanoparticles and are being formed at different times. Inset Fig. 3(i)(b) illustrates Scherrer rings in the SAED pattern which clearly indicates the formation nanocrystalline AAT particles. Indexing of SAED pattern revealed the monoclinic lattice structure, which is in agreement with XRD result.

The FTIR spectrum (Fig. 4) exhibits a prominent fundamental absorption band at 525 cm⁻¹, which is due to Ti–O vibration. Multiple peaks (A-O absorption bands) in the frequency region

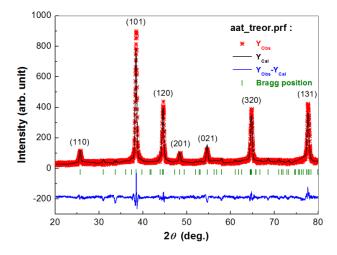


Fig. 1 Rietveld refined XRD pattern of nanocrystalline powder of $Al_{0.5}Ag_{0.5}TiO_3$ in the space group P2/m(10). Symbols represent observed data points and solid lines their Rietveld fit

Table 1 The crystal data and refinement factors of $Al_{0.5}Ag_{0.5}TiO_3$ obtained from X-ray powder diffraction data

Crystallographic data		Description of parameters:
Formula	Al _{0.5} Ag _{0.5} TiO ₃	
Crystal System	Monoclinic	$R_{\rm p}$ (profile factor) = $100[\Sigma y_i-y_{ic} /\Sigma y_i]$, where y_i is
Space group (No.)	<i>P</i> 2/ <i>m</i> (10)	the observed intensity and y_{ic} is the calculated
a (Å)	5.7819	intensity at the i^{th} step.
<i>b</i> (Å)	4.3314	
<i>c</i> (Å)	2.6611	$R_{\rm wp}$ (weighted profile factor) = $100[\Sigma\omega_i y_i-$
β (%)	94.6087	$R_{\rm wp}$ (weighted profile factor) = $100[\Sigma\omega_i y_i-y_{ic} ^2/\Sigma\omega_i(y_i)^2]^{1/2}$, where $\omega_i = 1/\sigma_i^2$ and σ_i^2 is variance
$V(\text{\AA}^3)$	66.4256	of the observation.
Data collection		
Temperature (°C)	24.0	R_{exp} (expected weighted profile factor) = 100[(<i>n</i> -
Wavelength [CuK _{α}] (Å)	1.5406	$p)/\Sigma\omega_i(y_i)^2$ ^{1/2} , where <i>n</i> and <i>p</i> are the number of
Monochromator	Graphite	profile points and refined parameters, respectively.
Measuring range (°)	$20 \le 2\theta \le 80$	
Step (°2 θ)	0.02	$R_{\rm B}$ (Bragg factor) = $100[\Sigma I_{\rm obs} - I_{\rm calc} / \Sigma I_{\rm obs}]$, where
Integration time (s)	30	$I_{\rm obs}$ is the observed integrated intensity and $I_{\rm calc}$ is the calculated integrated intensity.
Rietveld data		
Program	FULLPROF	$R_{\rm F}$ (crystallographic $R_{\rm F}$ factor) = $100[\Sigma F_{\rm obs}$ -
Function for background level	Polynomial 5-order	$F_{\text{calc}}/\Sigma F_{\text{obs}} $], where F is the structure factor, $F =$
Function for peak shape	Pseudo-Voigt	$\sqrt{(I/L)}$, where L is Lorentz polarization factor.
R _p	35.4	2
$R_{ m wp}$	31.1	$\chi^2 = \Sigma \omega_i (y_i - y_{ic})^2.$
$R_{\rm exp}$	27.5	
$R_{ m B}$	0.179	d (Durbin–Watson statistics) = $\Sigma \{ [\omega_i(y_i - y_{ic}) - \omega_{i-1}(y_{i-1} - \omega_{i-1})] \}$
$R_{\rm F}$	0.395	$(y_{ic-1})^{2}$ / $\Sigma[\omega_{i}(y_{i}-y_{ic})]^{2}$.
χ_{-}^{2}	1.28	
d	0.7402	Q_D = expected d .
$R_{\rm F}$ χ^2 d Q_D S	1.8996	
S	1.1309	S (goodness of fit) = (R_{wp}/R_{exp}).

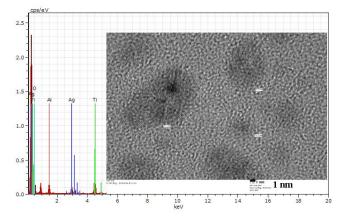


Fig. 2 EDX spectrum and HR-TEM image (inset) of nanocrystalline $Al_{0.5}Ag_{0.5}TiO_3$ powder

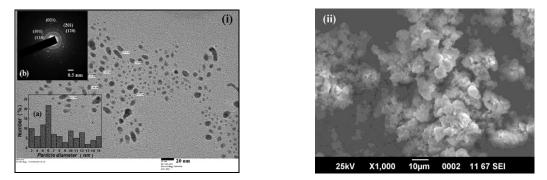


Fig. 3 (i) TEM image, particle size distribution (inset: a), SAED pattern (inset: b) and (ii) SEM image of nanocrystalline $Al_{0.5}Ag_{0.5}TiO_3$ powder

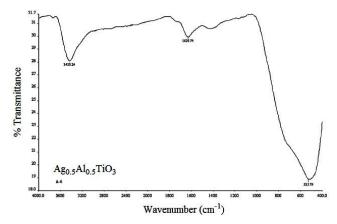


Fig. 4 FTIR spectrum of nanocrystalline Al_{0.5}Ag_{0.5}TiO₃ powder

900-1630 cm⁻¹ are due to the presence of Al-O and Ag-O vibrations (Kumar *et al.* 2013). Further, a broad and strong peak can easily be seen at 3430 cm⁻¹ which is due to free water molecules (H₂O bands) and strong stretching (antisymmetric and symmetric) modes of the OH group. No other band appeared in the FTIR spectrum clearly revealed the formation of Al_{0.5}Ag_{0.5}TiO₃ calcination at 700°C.

The schematic for the soft chemical synthesis of n-AAT is illustrated in Fig. 5. Citric acid and citrate ions are readily inter-convertible requiring and/or releasing an appreciable amount of free energy ($\Delta G \sim 47$ KJ/mol) in aqueous medium (Miller and Magowan 1990, Jha *et al.* 2011) which is probably sufficient enough to accomplish nano-transformation. Present nano-transformation mechanism could be understood using the nucleation and growth theory to form a spherical particle. According to which the overall free energy change must be overcome. ΔG is the indicative of sum of the free energy due to the formation of a new volume and the free energy due to the new surface created: $\Delta G = -\frac{4}{V} \pi r^3 k_B T \ln(S) + 4\pi r^2 \gamma$, where *V*, *r*, *k*_B, *S* and γ are the molecular volume of the prepared species, radius of the nucleus, Boltzmann constant, saturation ratio and surface free energy per unit surface area, respectively. It follows from equation that a decrease in γ or an increase in *S* is helpful in the formation of nanoparticles (n-AAT, in this case). Besides, R-COOH makes a non-equivalent resonating structure whereas RCOO⁻ efficiently makes

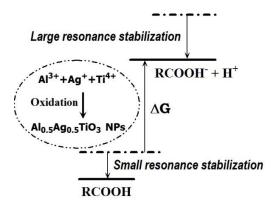


Fig. 5 Schematic for the synthesis of nanocrystalline Al_{0.5}Ag_{0.5}TiO₃ powder using citric acid gel method

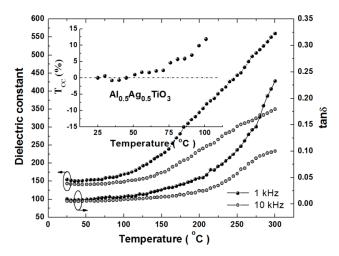


Fig. 6 Temperature dependence of dielectric constant and loss tangent of $Al_{0.5}Ag_{0.5}TiO_3$ ceramic pellet at 1 kHz and 10 kHz. Inset: Variation of $T_{CC}(\%)$ with temperature at 1 kHz

an equivalent one. This way, the resonance energy of stabilization of R-COOH is larger than that of RCOO⁻ and this energy of dissociation probably remains available all along in the incubation medium for nano-transformation of both metal as well as oxide system, as the case may be (Morrison and Boyd 1983, Jha *et al.* 2011). In the present soft-chemical method, the interactions of citric acid with Al^{3+} , Ag^+ and Ti^{4+} ions in stoichiometric ratio made it possible to lower down the surface energy. Therefore, the effect of such soft-chemical ambiance could have made the reaction to occur more easily.

Fig. 6 shows the variation of dielectric constant (ε) and loss tangent (tan δ) with temperature at 1 kHz and 10 kHz. It is observed that values of both ε and tan δ increase with increment in temperature in the investigated temperature range. The room temperature values of ε and tan δ are, respectively, found to be 155 and 0.0092 at 1 kHz. Since the observation was made for only in a limited range of temperature dielectric anomaly could not be observed as similar material *e.g.* (Ag_{0.5}Bi_{0.5})TiO₃ has very high phase transition temperature (~800 K) (Inaguma *et al.* 2001). It can

also be noted that the value of $\tan \delta$ are of the order of 10^{-2} in the working temperature range (up to 100°C). The low $\tan \delta$ of this kind can be advantageous when improved detectivity (pyroelectric applications) is required. Inset of Fig. 5 clearly illustrates that the values of T_{CC} varies within \pm 12% in the working temperature range (upto +100°C). Therefore, the low value of T_{CC} (< \pm 12%), ε' (=155) and low $\tan \delta$ (~10⁻²) were found in case of n-AAT ceramic, which meets the specifications for "Z7R" of Class I dielectrics of Electronic Industries Association. Therefore, this compound may be considered as a potential candidate for capacitor applications.

4. Conclusions

In summary, the present soft-chemical method is truly a green cost-effective approach, capable of producing nanocrystalline Al_{0.5}Ag_{0.5}TiO₃ powder. Nanocrystalline AAT powder was found to have a perovskite-type monoclinic structure with the particle sizes of 3-15 nm. EDX and FTIR studies confirmed the formation of pure AAT. A decrease in surface free energy per unit surface area or an increase in saturation ratio is helpful in the formation of AAT nanoparticles. Dielectric study revealed that this compound is having low dielectric constant (= 155), loss tangent (= 0.0092) at 1 kHz and a low T_{CC} (< ±12%) in the working temperature range (upto +100°C) which makes this material suitable for capacitor application and may be designated as 'Z7R' Class I material as per the specifications of the Electronic Industries Association.

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References

Cross, L.E. (2004), "Lead-free at last", Nature, 432, 24-25.

- Damjanovic, D., Klein, N., Li, J. and Porokhonskyy, V. (2010), "What can be expected from lead-free piezoelectric materials?", *Funct. Mater. Lett.*, **3**, 5-13.
- Eichel, R.A. and Kungl, H. (2010), "Recent developments and future perspectives of lead-free ferroelectrics", *Funct. Mater. Lett.*, **3**, 1-4.
- Fancher, C.M., Blendell J. E. and Bowman, K.J. (2013), "Poling effect on d₃₃ in textured Bi_{0.5}Na_{0.5}TiO₃-based materials", *Scripta Materialia*, **68**, 443-446.

Hiruma, Y., Nagata, H. and Takenaka, T. (2009), "Thermal depoling process and piezoelectric properties of bismuth sodium titanate ceramics", J. Appl. Phys., 105, 084112-084120.

- Inaguma, Y., Katsumata, T., Wang, R., Kobashi, K., Itoh, M., Shan, Y.-J. and Nakamura, T. (2001), "Synthesis and dielectric properties of a perovskite Bi_{1/2}Ag_{1/2}TiO₃", *Ferroelectr.*, **264**, 127-132.
- Jha, A.K., Kumar, V. and Prasad, K. (2011), "Biosynthesis of metal and oxide nanoparticles using orange juice", J. Bionanosci., 5, 162-165.
- Kumar, S., Sahay, L.K., Jha, A.K. and Prasad, K. (2013), "Synthesis of (Ag_{0.5}Fe_{0.5})TiO₃ nanocrystalline powders using stearic acid gel method", *Adv. Mater. Lett.*, DOI: 10.5185/amlett.2013.fdm.06.

Kumari, K., Prasad, A. and Prasad, K. (2011), "Structural and dielectric properties of ZnO added

(Na_{1/2}Bi_{1/2})TiO₃ ceramic", J. Mater. Sci. Technol., 27, 213-217.

- Liao, Y., Xiao, D. and Lin, D. (2008), "Piezoelectric and ferroelectric properties of Bi_{0.5}(Na_{1-x-y}K_xAg_y)_{0.5}TiO₃ lead-free piezoelectric ceramics", *Appl. Phys. A: Mater. Sci. Process*, **90**, 165-169.
- Lu, Y., Li, Y., Wang, D. and Yin, Q. (2007), "Morphotropic phase boundary and electrical properties of (Bi_{1/2}Na_{1/2})TiO₃-(Bi_{1/2}K_{1/2})TiO₃-(Bi_{1/2}Ag_{1/2})TiO₃ ceramics", *Ferroelectr.*, **358**, 109-116.
- Lu, Y., Li, Y., Wang, D., Wang T. and Yin, Q. (2008), "Lead-free piezoelectric ceramics of (Bi_{1/2}Na_{1/2})TiO₃-(Bi_{1/2}Ag_{1/2})TiO₃-(Bi_{1/2}Ag_{1/2})TiO₃ system", *J. Electroceram.*, **21**, 309-313.
- McCusker, L.B., Von Dreele, R.B., Cox, D.E., Louër, D. and Scardi, P. (1999), "Rietveld refinement guidelines", J. Appl. Cryst., 32, 36-50.
- Miller, S. L. and Magowan, D. S. (1990), "The thermodynamics of the Krebs cycle and related compounds", *J. Phys. Chem. Re. Data*, **19**, 1049-1070.
- Morrison, R.T. and Boyd, R.N. (1983), Advanced Organic Chemistry, Allyn and Bacon Inc., Boston, USA.
- Park, J.H., Woodward, P.M., Parise, J.B., Reeder, R.J., Lubomirsky, I. and Stafsudd, O. (1999), "Synthesis, structure, and dielectric properties of (Bi_{1/2}Ag_{1/2})TiO₃", *Chem. Mater.*, **11**, 177-183.
- Prasad, A., Roy, A.K. and Prasad, K. (2013), "Electrical conduction in $(Na_{0.5}Bi_{0.5})_{1-x}Ba_xTiO_3$ ($0 \le x \le 1$) ceramic by complex impedance/modulus spectroscopy", *ISRN Ceram*", **2013**, Article ID 369670, 12 pages.
- Prasad, K., Kumari, K., Lily, Chandra, K.P., Yadav, K.L. and Sen, S. (2007), "Electrical conduction in (Na_{0.5}Bi_{0.5})TiO₃ ceramic: Impedance spectroscopy analysis", *Adv. Appl. Ceram.*, **106**, 241-246.
- Raevskii, I.P., Reznichenko, L.A. and Malitskaya, M.A. (2000), "Features in the dielectric properties and temperature-composition phase diagrams of NaNbO₃-A_{0.5}Bi_{0.5}TiO₃ (A = Li, Na, K, Ag) solid solutions", *Tech. Phys. Lett.*, 26, 93-95.
- Rödel, J., Jo, W., Seifert, K.T.P., Anton, E.M., Granzow, T. and Damjanovic, D. (2009), "Perspective on the Development of Lead-free Piezoceramics", J. Am. Ceram. Soc., 92, 1153-1177.
- Shrout, T.R. and Zhang, S.J. (2007), "Lead-free piezoelectric ceramics: alternatives for PZT?", J. *Electroceram.*, **19**, 111-124.
- Smolenskii, G.A., Isupov, V.A., Agranovskaya, A.I. and Krainik, N.N. (1961), "New ferroelectrics of complex composition IV", Sov. Phys. Solid State, 2, 2651-2654.
- Takenaka, T. and Nagata, H. (2005), "Current status and prospects of lead-free piezoelectric ceramics", J. *Euro. Ceram. Soc.*, **25**, 2693-2700.
- Wu, L., Xiao, D., Zhou, F., Teng, Y. and Li, Y. (2011), "Microstructure, ferroelectric, and piezoelectric properties of (1-*x*-*y*)Bi_{0.5}Na_{0.5}TiO₃-*x*BaTiO₃-*y*Bi_{0.5}Ag_{0.5}TiO₃ lead-free ceramics", *J. Alloys Comp.*, **509**, 466-470.

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